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The influence of the electron transport layer on charge dynamics and trap-state properties in planar perovskite solar cells†

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Despite the outstanding photovoltaic performance of perovskite solar cells, the correlation between the electron transport layer and the mechanism of photoelectric conversion is still not fully understood. In this paper, the relationship between photovoltaic performance and carrier dynamics is systematically studied in both TiO₂- and SnO₂-based planar perovskite devices. It is found that the different electron transport layers result in distinct forward scan results and charge dynamics. Based on the charge dynamics results, the influence of the electron transport layer on charge carrier transport and charge recombination is revealed. More importantly, the trap-state density is characterized, which is proven to be related to the charge carrier dynamics and the specific hysteresis behaviour in the perovskite solar cells. The present work would provide new insights into the working mechanisms of electron transport layers and their effect on hysteresis.

1. Introduction

Perovskite solar cells (PSCs) have attracted great attention in recent years. The certified efficiency of PSCs has skyrocketed to 25.2%,¹ owing to the superb optoelectronic properties of the organic–inorganic hybrid perovskite materials, including high photoabsorption coefficients,² tunable band gaps,³ high charge mobilities,⁴ and ambipolar characteristics.⁵ The photovoltaic performance and device stability of PSCs is improved by optimizing the morphology of each functional layer and device structure, controlling crystallization of perovskites and engineering the interfacial structure. However, the PSCs performance could be further improved before commercialization by improving their environmental stability and electrical hysteresis.

A typical PSC consists of a perovskite layer sandwiched between an electron transport layer (ETL) and a hole transport layer (HTL). The outstanding photovoltaic performance of PSCs depends strongly on the property of the ETL in the devices. The ETL plays an important role in achieving high power conversion efficiency (PCE). ETLs not only influence the charge transfer and charge collection, but also behave as the hole blocking layer to suppress the electron–hole recombination at the interface.

Hence, ETLs may dictate the open circuit voltage as well as the fill factor of solar cells. In principle, an ideal ETL needs to meet the following criteria:^{6,7} (i) well aligned energy levels for efficient charge transfer and hole blocking, which reduces open voltage loss and improves electron transport from perovskite to the ETL; (ii) high electron mobility in ETL, which facilitates high efficiency charge extraction from the perovskite films and reduces charge recombination; (iii) high optical transmittance, which reduces the optical energy loss; (iv) high stability, easy processing and low cost, which are essential for the final commercialization of PSCs.

Thus far, TiO₂ is the most commonly used electron transport material. However, it requires high temperature sintering to obtain a dense, good quality TiO₂ ETL with relatively high crystallinity and conductivity. This high temperature process hinders its application in simple and cost-effective production of solar cells on flexible substrates. Moreover, the electron mobility of TiO₂ ETL is too low (0.1–10 cm² V⁻¹ s⁻¹) to match with that of the perovskite layer (24.81 cm² V⁻¹ s⁻¹), which limits the electron transport and increases the possibility of charge recombination,⁸ when a HTL with high hole mobility is used.^{6,9} Recently, low-temperature prepared stannic oxide (SnO₂), regarded as a better alternative ETL, has been investigated.^{10,11} Ke *et al.* first demonstrated a regular planar PSC with high PCE and improved hysteresis using SnO₂ as the ETL.¹² Compared to TiO₂, SnO₂ exhibits many advantages for PSCs.^{13,14} SnO₂ has 100 times higher electron mobility (up to 240 cm² V⁻¹ s⁻¹)¹⁵ and a deeper conduction band.^{16,17} Also, with a wide bandgap of ~4.0 eV, SnO₂ absorbs much less UV light, resulting in higher chemical stability than TiO₂.

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Planar perovskite solar cells based on TiO₂ and SnO₂ ETLs also exhibit different photovoltaic performances represented in their hysteresis.^{18–20} Therefore, it is interesting to establish how the ETLs affect the behavior of the hysteresis. Furthermore, the understanding of the correlation between ETLs charge dynamics and photovoltaic performance is still limited.

In this work, TiO₂- and SnO₂-based planar PSCs are prepared and compared in their photovoltaic performances. Charge carrier transport/recombination dynamics of PSCs from different ETLs are systematically investigated by transient photocurrent and photovoltage measurements. Furthermore, the trap-state properties are explored using time-resolved charge extraction. By taking the dynamics results into account, the influence of ETLs on photovoltaic performances and charge dynamics are comprehensively discussed.

2. Experimental section

2.1 Fabrication of PSCs

Unless otherwise stated, all materials were purchased from Alfa Aesar and used as received. The FTO glass substrates were sequentially coated of compact TiO₂ and SnO₂ thin films, respectively, followed by depositing of perovskite precursors by the antisolvent method.^{21,22} The hole transport layer was successively spin-coated after thermal annealing of the perovskite active layer (at 100 °C for 1 h). Finally, 60 nm of Au was thermally evaporated as the counter electrode. The detailed PSCs construction information was included in the ESI.†

2.2 Characterization

The morphologies of the perovskite films were characterized by field-emission scanning electron microscopy (FE-SEM, Hitachi SU8010) at an accelerating voltage of 5 kV. X-ray diffraction (XRD) analysis was conducted on a Shimadzu XRD-7000 using Cu-K α radiation in the 2θ range from 10° to 60° at a scan rate of 2° per min. UV-vis absorption measurements were performed on a Shimadzu UV-3600 spectrometer. The steady-state photoluminescence (PL) spectroscopy measurements (Edinburgh FLS980 spectrometer) were carried out at an excitation wavelength of 510 nm with irradiation from the side of spin-coated materials.

The current density (J)-voltage (V) characteristics were obtained by exposing the PSCs to a standardized solar simulator, which was calibrated by a standard silicon reference cell to AM 1.5G illumination (100 mW cm⁻²). The applied bias voltage was swept from open circuit to short circuit (reverse scan) and backwards (forward scan) at a scan rate of 1 mV s⁻¹ without light soaking or voltage treatment history. A metal aperture mask was used to define the active area to 0.1 cm², and all data was acquired by a sourcemeter (Keithley 2400).

2.3 Transient photovoltage (TPV) and transient photocurrent (TPC) measurements

TPV and TPC measurements were conducted following previous reports.^{23,24} The cell was illuminated from the substrate side by a green light-emitting diode (LED) with central wavelength of

530 ± 5 nm to generate different open circuit photovoltages (V_{ph}). The illumination was superimposed with weak laser pulses (532 nm, 7 ns) as the intensity modulation, which creates an open circuit photovoltage modulation, ΔV_{ph} . The intensity of the pulsed laser was adjusted by neutral filters so that ΔV_{ph} is less than 5% of V_{ph} . By adjusting the intensity of LED, a series of desired V_{ph} were obtained. The results of TPV were recorded by an oscilloscope (64Xs, Lecroy) with 1 M Ω of input impedance, while TPC results were recorded with 50 Ω of input impedance.

2.4 Time-resolved charge extraction measurement

The time-resolved charge extraction (TRCE) measurements were conducted as previously reported.²⁵ Briefly, a laser diode (530 nm) was used as the excitation source, and an analogous electric switch with a response time of 10 ns was connected to the PSC device in parallel circuit. Both perovskite devices and the electric switch were controlled by a digital delay and pulse generator (DG535, Stanford Research System). The measurements were taken by switching between open-circuit and short-circuit conditions at different given time. Open circuit represented that 1 M Ω was paralleled with the device, which recorded the photovoltage evolutions. Meanwhile, the short circuit condition means that 50 Ω was paralleled with the device to characterize the charge extraction process. The evolution of the electric signals were recorded by a digital oscilloscope (64Xs, Lecroy).

3. Results and discussion

The morphologies of perovskite active layers deposited on TiO₂ and SnO₂ ETLs are displayed in Fig. 1a and b. Both perovskite films are uniform with good crystal quality, a similar compact texture with grain sizes which are in the range of hundreds of nanometers. The perovskite films with high coverage and quality can effectively absorb and utilize light, which in turn facilitates charge excitation, contributing to the photoelectric conversion and photovoltaic performance.²³ It is believed that the nature of substrates could strongly influence the growth of perovskite film.^{26–28} Obviously, in our case, the grain size of perovskite based SnO₂ (~291 nm) ETL is larger than that on TiO₂ (~247 nm) substrate (shown as inserted histograms in Fig. 1a and b). Detailed statistics of the perovskite grain sizes are shown in Fig. S1.† Larger perovskite grain sizes obtained on the SnO₂ ETL suggests that SnO₂ is more favorable for the growth of perovskite. Enlarged grains with reduced density of grain boundaries and defects in the perovskite films can effectively improve the device performance.^{27,29} XRD patterns reveal the phase compositions and crystallinities of the perovskite films on different ETLs. As shown in Fig. 1c and d, both films exhibit the same dominant diffraction peaks from the (110) and (220) planes at around 14.7° and 29.0°,^{30,31} respectively, which are the characteristic peaks for a tetragonal perovskite. There is no obvious difference in the XRD patterns, suggesting that the crystal structures of the perovskite films are almost identical on TiO₂ and SnO₂ ETLs.



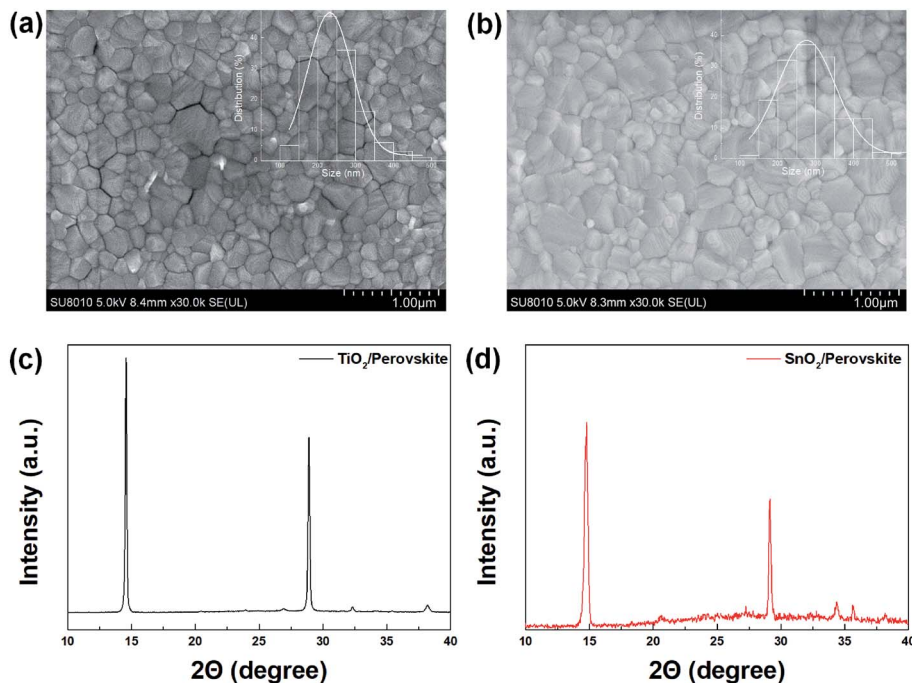


Fig. 1 Top-view SEM images of perovskite films on (a) TiO_2 and (b) SnO_2 substrates, and corresponding XRD patterns of the (c) TiO_2 -based and (d) SnO_2 -based samples. The inset in (a) and (b) show the corresponding crystal size distributions.

The UV-vis absorption spectra of perovskite films deposited on quartz, TiO_2 and SnO_2 are shown in Fig. 2a, respectively. The perovskite films on these three different substrates exhibit nearly identical absorption intensities and profiles from the UV-visible to the near-infrared region with the absorption onset at 780 nm. The steady-state PL measurements were also carried out to investigate the charge transfer kinetics of photogenerated carriers transporting from perovskite films to the TiO_2 and SnO_2 ETLs. To exclude the thickness effect, the cross-section SEM images of the devices are shown in Fig. S2,[†] demonstrating that the perovskite films with the same thickness on different substrates. Hence, the steady-state PL intensity (Fig. 2b) represents the probability of charge extraction through the interfaces from the perovskite films to the ETLs. Given the absorption

spectra of the perovskite films are independent to the nature of the substrates (Fig. 2a), the lowest PL intensity from the SnO_2 ETL suggests a stronger charge extract capability of SnO_2 in comparison to TiO_2 .

The representative J - V characteristics of the best PSCs based on TiO_2 and SnO_2 are presented in Fig. 3, and corresponding photovoltaic parameters are summarized in Fig. 3c. It is clear that there are no significant differences short-circuit current (J_{SC}), open-circuit voltage (V_{OC}), fill factor (FF) and PCE between TiO_2 and SnO_2 based PSCs in the reverse scans. However, the performances in the forward scans are significantly different between TiO_2 - and SnO_2 -based PSCs. Due to a much lower performance of TiO_2 -PSC in the forward scan (Fig. 3a), its hysteresis phenomenon is much more remarkable than that

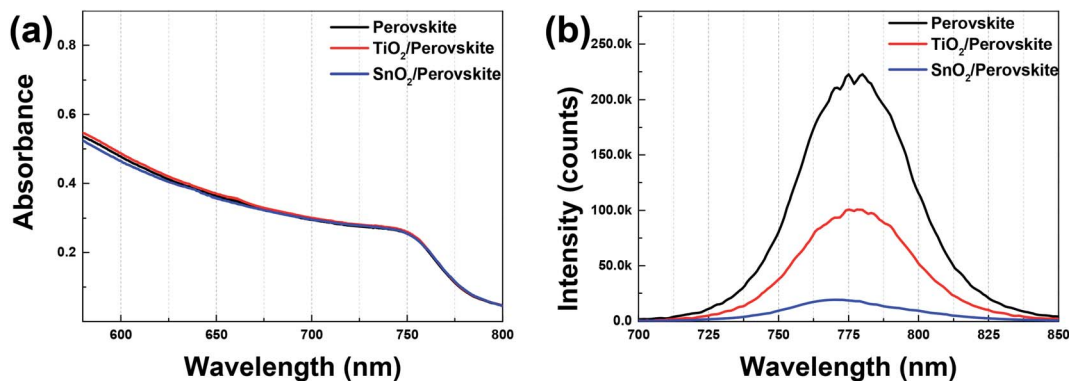


Fig. 2 (a) UV-vis absorption and (b) steady-state PL spectra of perovskite films deposited on quartz (black), TiO_2 (red) and SnO_2 (blue), respectively.



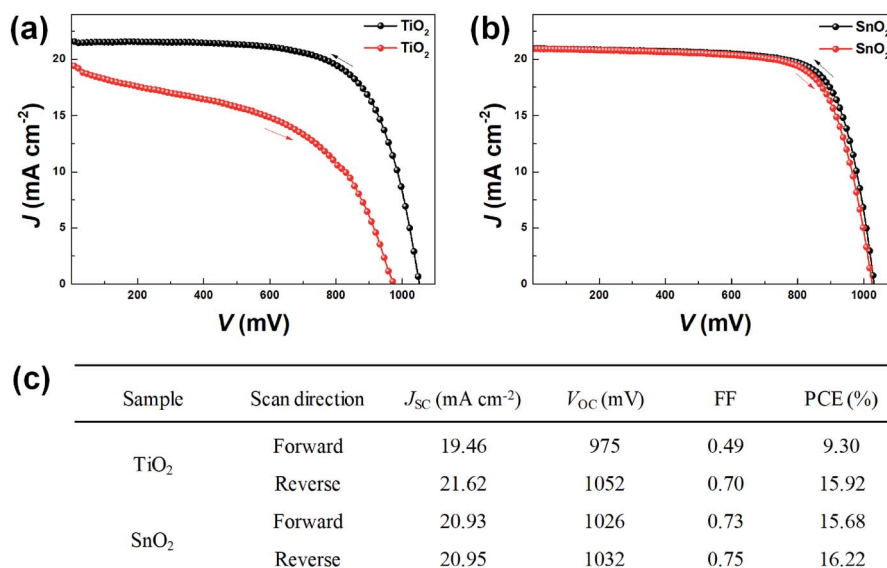


Fig. 3 J - V curves obtained from the best device with (a) TiO₂- and (b) SnO₂-based solar cells, respectively. Black curves are the reverse scan and red curves are the forward scan. (c) Photovoltaic performance of the corresponding solar cells under simulated 1 sun illumination (AM 1.5, 100 mW cm⁻²).

from the SnO₂-based PSC (Fig. 3b). The photovoltaic parameters of TiO₂-based PSCs (*i.e.*, FF and PCE) obtained from the forward scan are much lower than those obtained from the reverse scan. For detail, as listed in Fig. 3c, SnO₂-based device showed a V_{OC} of 1032 mV, a J_{SC} of 20.95 mA cm⁻², a FF of 74.88%, and a PCE of 16.22% under reverse scan, which are slightly decreased to 1026 mV, 20.93 mA cm⁻², 73.06% and 15.68%, respectively, under forward scan. However, for TiO₂-based PSC, all parameters, including V_{OC} , J_{SC} , FF and PCE are decreased in the forward scan. To evaluate the hysteresis quantitatively, we calculated the hysteresis index, defined as $(PCE_{reverse} - PCE_{forward})/PCE_{reverse}$.³² SnO₂-PSC exhibited the smaller hysteresis index of 3.3%, in contrast to 41.6% for the TiO₂-PSC. This observation is in agreement with published literature.^{13,33}

The observed hysteresis from the PSCs were further confirmed by analyzing large number of PSCs devices based on either TiO₂ or SnO₂ ETLs prepared to investigate under identical conditions. The statistical results of the photovoltaic parameters of fifteen PSCs, including J_{SC} , V_{OC} , FF and PCE, are shown in Fig. 4. It is clear that the severe hysteresis phenomenon for TiO₂-PSC and low hysteresis for SnO₂-PSC are highly reproducible. The mechanisms behind the photovoltaic performance and distinct hysteresis of the two types of PSCs will be further explored in depth below.

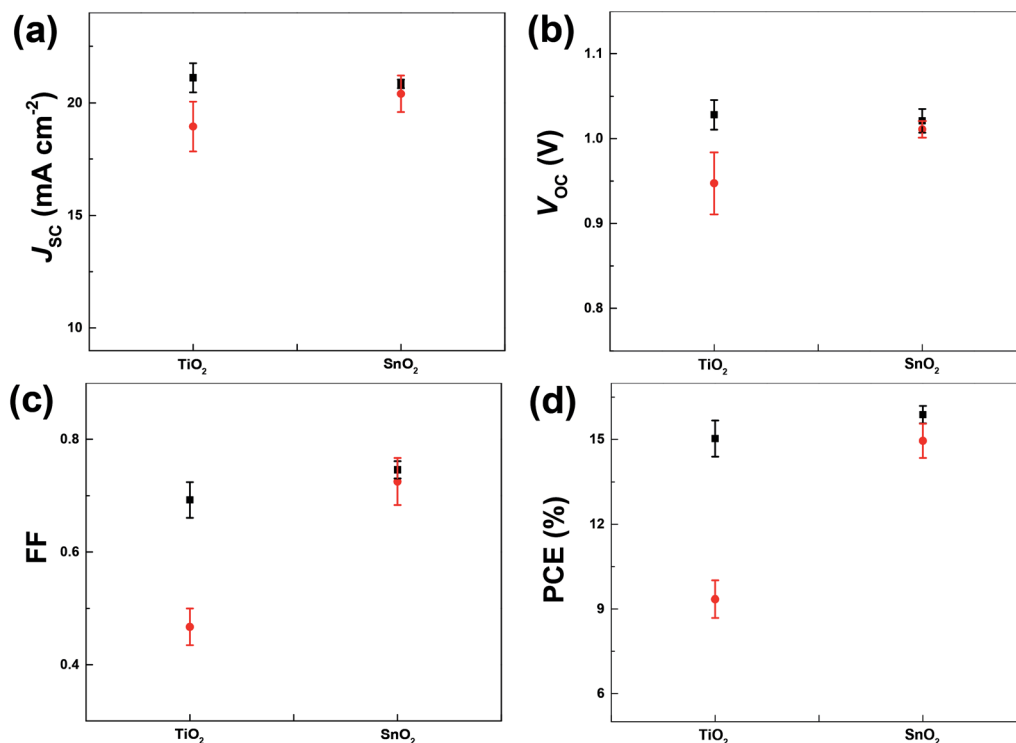
To elucidate the underlying mechanism of charge carrier recombination and transport process in the devices, TPV and TPC measurements were performed. These techniques have been widely employed for exploring the carrier behavior in solar cells.^{24,34,35} Several TPV and TPC curves extracted from the original results are displayed in Fig. S3.† The photovoltage (V_{ph}) decay traces were fitted with a bi-exponential function, and the apparent recombination time constant τ_r and transport time constant τ_t was calculated according to $\tau = (A_1\tau_1 + A_2\tau_2)/(A_1 + A_2)$.

Fig. 5 shows the τ_r and τ_t as a function of V_{ph} for both TiO₂-PSC and SnO₂-PSC devices. Overall, charge recombination rates were increased with the increase of V_{ph} . This is due to the accumulation of large number photo-induced carriers at high V_{ph} which accelerates the charge recombination process. For both devices, a pseudo linear correlation between τ_r and V_{ph} at the semi-logarithmic plot was observed,^{23,24} which suggests that the carrier recombination follows the trap-limited recombination.^{36,37} Meanwhile, the τ_r for the TiO₂-PSC is always less than that for the SnO₂-PSC over the entire V_{ph} range. This confirms a faster carrier recombination in TiO₂-PSC, which is generally detrimental to the photovoltaic performance.

The dependency of τ_t on V_{ph} is shown in Fig. 5b, which exhibits a nearly constant value for each of the cells, similar to those in the literatures.^{23,38,39} Moreover, it was found that the photocurrent decay time constant was significantly reduced from 0.25 μ s to 0.11 μ s (Fig. 5b), when TiO₂ is replaced by SnO₂ as the ETL. This indicates a dramatic improvement of charge extraction efficiency by SnO₂, which is consistent with the reduced recombination rate and low hysteresis from SnO₂, as shown in Fig. 3. In principle, it could be proposed that by passivation of trap-states, the charge recombination is effectively suppressed and the charge transport is significantly improved for the SnO₂ ETL, thus the hysteresis of the device is eliminated.

TRCE is an effective technique to evaluate charge distribution within the solar cells. The extracted charge (Q) at different photovoltage was obtained by integrating the extraction current curves vs. decay time (Fig. S4†), shown in Fig. 6. It is clear that the two cells showed similar extracted charge at the low V_{ph} region (≤ 300 mV). However, by increasing V_{ph} (> 300 mV), the Q value of a TiO₂-PSC increases more rapidly in comparison to SnO₂. In addition, the Q values are exponentially dependent on





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Fig. 4 The statistical photovoltaic parameters (J_{SC} , V_{OC} , FF, and PCE) under reverse scan and forward scan of TiO₂- and SnO₂-based planar PSCs. Black squares are the reverse scan results and red solid circles are the forward scan results.

the photovoltages. Normally, the distribution of the trap-state density is proportional to the chemical capacitance (C_{μ}) of the device,^{40–42} which is defined by $C_{\mu} = dQ/dV$. Hence, the exponential increase of Q vs. V_{ph} suggests an exponential distribution of trap state density. Meanwhile, the faster increase of extracted charge Q in a TiO₂-PSC device (Fig. 6) indicates that the TiO₂ ETL and/its interface with perovskite contains the higher trap state density. High density of trap states in TiO₂ can act as recombination centers in the PSC devices. This is responsible for the interfacial charge accumulation and the

increased interfacial charge recombination, demonstrated in Fig. 3 and 5.

Given the direct comparison of PL, TPV, TPC and TRCE results, one can systematically observe the difference in the charge dynamics between the TiO₂-PSC and SnO₂-PSCs. Therefore, we can propose a detailed scheme describing the effect of trap state density in the ETL in perovskite solar cells. As illustrated in Fig. 6b and c, the photogenerated charge carriers in the perovskite phase can be rapidly injected into the conduction bands of the ETLs. Larger trap-state densities at the TiO₂/

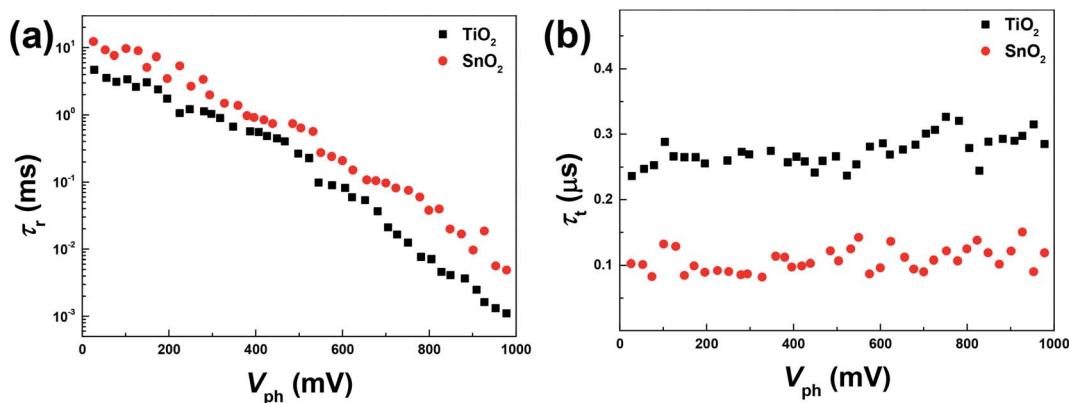


Fig. 5 (a) V_{ph} -dependent charge carrier recombination and (b) charge transport constants derived from the TPV and TPC measurements for TiO₂- and SnO₂-based planar PSCs respectively.



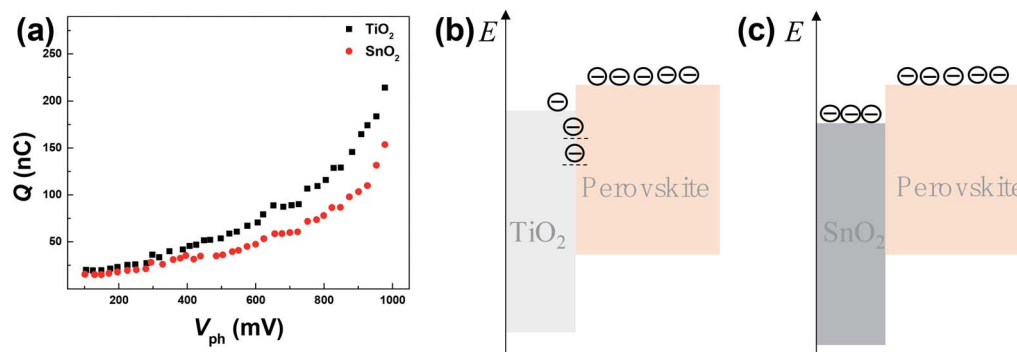


Fig. 6 (a) Extracted charge as a function of V_{ph} from a TiO_2 -PSC (black) and a SnO_2 -PSC, (b) energy level diagram of TiO_2 /perovskite and (c) SnO_2 /perovskite. The minus signs represent excited electrons and the dotted line represents the defect.

perovskite interface (Fig. 6b) decrease the charge extraction resulting in increased charge accumulation and charge recombination. In comparison to TiO_2 , SnO_2 has a deeper conduction band with lower trap-state density (Fig. 6c), which promotes the charge extraction and, more importantly, the overall photovoltaic performance, resulting in a hysteresis-free PSC. This mechanism suggests that the interface between perovskite and the ETL plays a crucial role in the PSC hysteresis.

4. Conclusions

In conclusion, photovoltaic performance and charge carrier dynamics have been systematically studied in TiO_2 -PSC and SnO_2 -PSC. Both TiO_2 -PSC and SnO_2 -PSC yield an average efficiency $\sim 16\%$ under reverse scan conditions, while SnO_2 -PSC is almost hysteresis-free. TRCE and the transient photoelectric results confirm that ETLs exhibit a prominent effect on the modification of the trap-states properties, which are closely related to the apparent charge carrier dynamics and the photovoltaic performances. In comparison to TiO_2 , SnO_2 ETL offers better charge extraction and charge transport with reduced charge recombination due to the effective passivation of the trap states at the interface, which eliminated $J-V$ hysteresis completely. Our results give new insights into the influence of ETLs on the performance of perovskite solar cell devices. It reveals that the underlying mechanism is important for optimization the structure and properties of the ETL/perovskite interface and hence, further improvement in PSC performances.

Conflicts of interest

There are no conflicts of interest to declare.

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